

## 1. General description

Planar passivated high commutation three quadrant triac in a SOT223-2L plastic package. This "series ET" triac balances the requirements of commutation performance and gate sensitivity and is intended for interfacing with low power drivers and logic ICs including microcontrollers.

## 2. Features and benefits

- 3Q technology for improved noise immunity
- Direct gate triggering from low power drivers and logic ICs
- High commutation capability with very sensitive gate
- High voltage capability
- Planar passivated for voltage ruggedness and reliability
- Sensitive gate for easy logic level triggering
- Triggering in three quadrants only

## 3. Applications

- Low power motor controls
- Small inductive loads e.g. solenoids, door locks, water valves
- Small loads in large white goods

## 4. Quick reference data

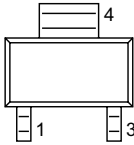
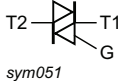
Table 1. Quick reference data

| Symbol                         | Parameter                           | Conditions   | Notes | Values     |     |     | Unit |
|--------------------------------|-------------------------------------|--|-------|------------|-----|-----|------|
| <b>Absolute maximum rating</b> |                                     |  |       |            |     |     |      |
| $V_{DRM}$                      | repetitive peak off-state voltage   |  |       | 800        |     |     | V    |
| $I_{T(RMS)}$                   | RMS on-state current                | square-wave pulse; $T_{sp} \leq 111\text{ °C}$ ;<br><a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a> |       | 1          |     |     | A    |
| $I_{TSM}$                      | non-repetitive peak forward current | full sine wave; $t_p = 20\text{ ms}$ ; $T_{j(init)} = 25\text{ °C}$ ;<br><a href="#">Fig. 4</a> ; <a href="#">Fig. 5</a>     |       | 11         |     |     | A    |
|                                |                                     | full sine wave; $t_p = 16.7\text{ ms}$ ; $T_{j(init)} = 25\text{ °C}$  |       | 12.1       |     |     | A    |
| $T_j$                          | operating junction temperature      |  |       | -40 to 150 |     |     | °C   |
| <b>Static characteristics</b>  |                                     |  |       |            |     |     |      |
| Symbol                         | Parameter                           | Conditions   | Notes | Min        | Typ | Max | Unit |
| $I_{GT}$                       | gate trigger current                | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2+ G+<br>$T_j = 25\text{ °C}$ ; <a href="#">Fig. 7</a>                         |       | 0.5        | -   | 10  | mA   |
|                                |                                     | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2+ G-<br>$T_j = 25\text{ °C}$ ; <a href="#">Fig. 7</a>                         |       | 0.5        | -   | 10  | mA   |
|                                |                                     | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2- G-<br>$T_j = 25\text{ °C}$ ; <a href="#">Fig. 7</a>                         |       | 0.5        | -   | 10  | mA   |
| $I_H$                          | holding current                     | $V_D = 12\text{ V}$ ; $T_j = 25\text{ °C}$ ; <a href="#">Fig. 9</a>  |       | -          | -   | 12  | mA   |
| $V_T$                          | on-state voltage                    | $I_T = 0.85\text{ A}$ ; $T_j = 25\text{ °C}$ ; <a href="#">Fig. 10</a>   |       | -          | -   | 1.6 | V    |

| Symbol                         | Parameter                             | Conditions   | Notes | Min | Typ | Max | Unit             |
|--------------------------------|---------------------------------------|--|-------|-----|-----|-----|------------------|
| <b>Dynamic characteristics</b> |                                       |  |       |     |     |     |                  |
| $dV_D/dt$                      | rate of rise of off-state voltage     | $V_{DM} = 536 \text{ V}$ ; $T_j = 150 \text{ }^\circ\text{C}$ ; ( $V_{DM} = 67\%$ of $V_{DRM}$ ); exponential waveform; $R_{GK} = 100 \text{ } \Omega$   |       | 600 | -   | -   | V/ $\mu\text{s}$ |
| $dI_{com}/dt$                  | rate of change of commutating current | $V_D = 400 \text{ V}$ ; $T_j = 125 \text{ }^\circ\text{C}$ ; $I_{T(RMS)} = 0.8 \text{ A}$ ; $dV_{com}/dt = 10 \text{ V}/\mu\text{s}$ ; gate open circuit |       | 1.6 | -   | -   | A/ms             |

## 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description     | Simplified outline   | Graphic symbol  |
|-----|--------|-----------------|--|---|
| 1   | T1     | main terminal 1 |  | <br>sym051 |
| 3   | G      | gate            |  |   |
| 4   | T2     | main terminal 2 |  |   |

## 6. Ordering information

Table 3. Ordering information

| Type number   | Package Name | Orderable part number | Packing method | Small packing quantity | Package version | Package issue date |
|---------------|--------------|-----------------------|----------------|------------------------|-----------------|--------------------|
| BTA301V-800ET | SOT223-2L    | BTA301V-800ETF        | Reel           | 4000                   | SOT223d-2L      | 02-Apr-2025        |

## 7. Marking

Table 4. Marking codes

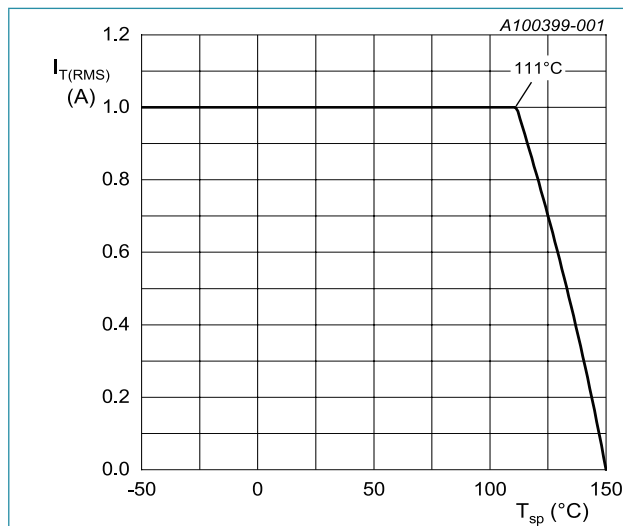
| Type number   | Marking codes |
|---------------|---------------|
| BTA301V-800ET | 301V8E        |

## 8. Limiting values

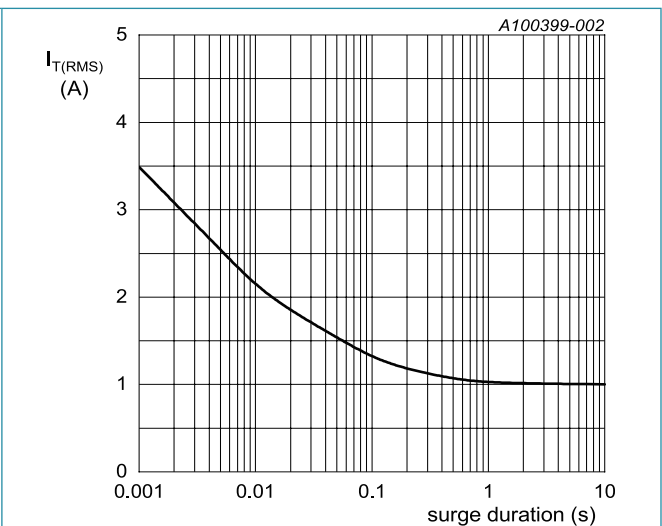
**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

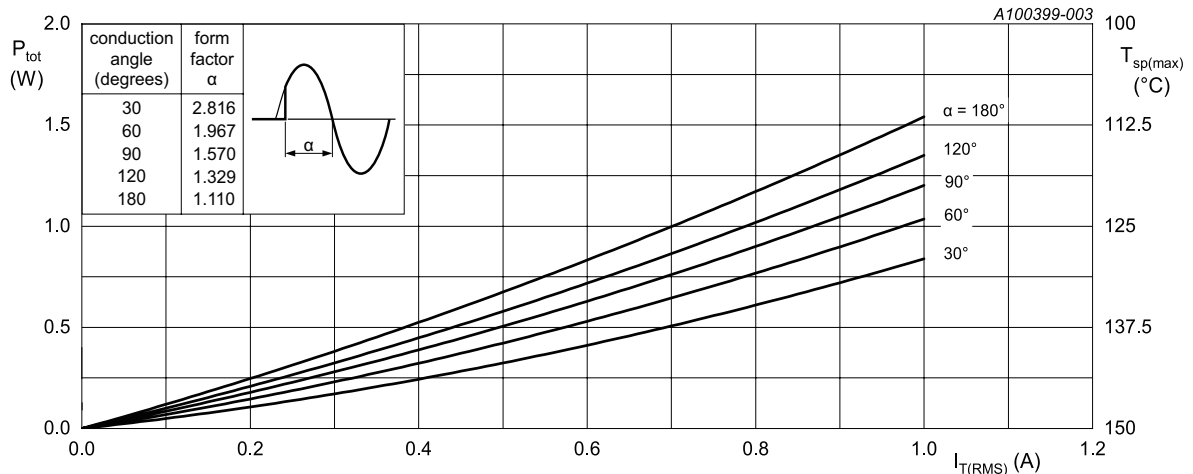
| Symbol       | Parameter                            | Conditions  | Notes | Values     | Unit                   |
|--------------|--------------------------------------|---|-------|------------|------------------------|
| $V_{DRM}$    | repetitive peak off-state voltage    |   |       | 800        | V                      |
| $V_{RRM}$    | repetitive peak reverse voltage      |   |       | 800        | V                      |
| $I_{T(RMS)}$ | RMS on-state current                 | full sine wave; $T_{sp} \leq 111^{\circ}\text{C}$ ;<br><a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a>       |       | 1          | A                      |
| $I_{TSM}$    | non-repetitive peak on-state current | full sine wave; $t_p = 20\text{ ms}$ ; $T_{j(\text{init})} = 25^{\circ}\text{C}$ ;<br><a href="#">Fig. 4</a> ; <a href="#">Fig. 5</a> |       | 11         | A                      |
|              |                                      | full sine wave; $t_p = 16.7\text{ ms}$ ; $T_{j(\text{init})} = 25^{\circ}\text{C}$  |       | 12.1       | A                      |
| $I^2t$       | $I^2t$ for fusing                    | $t_p = 10\text{ms}$ ; sine wave   |       | 0.61       | $\text{A}^2/\text{s}$  |
| $di_T/dt$    | rate of rise of on-state current     | $I_G = 10\text{mA}$   |       | 100        | $\text{A}/\mu\text{s}$ |
| $I_{GM}$     | peak gate current                    |   |       | 1          | A                      |
| $P_{GM}$     | peak gate power                      |   |       | 2          | W                      |
| $P_{G(AV)}$  | average gate power                   | over any 20 ms period   |       | 0.1        | W                      |
| $T_{stg}$    | storage temperature                  |   |       | -40 to 150 | $^{\circ}\text{C}$     |
| $T_j$        | operating junction temperature       |   |       | -40 to 150 | $^{\circ}\text{C}$     |



**Fig. 1. RMS on-state current as a function of solder point temperature; maximum values**

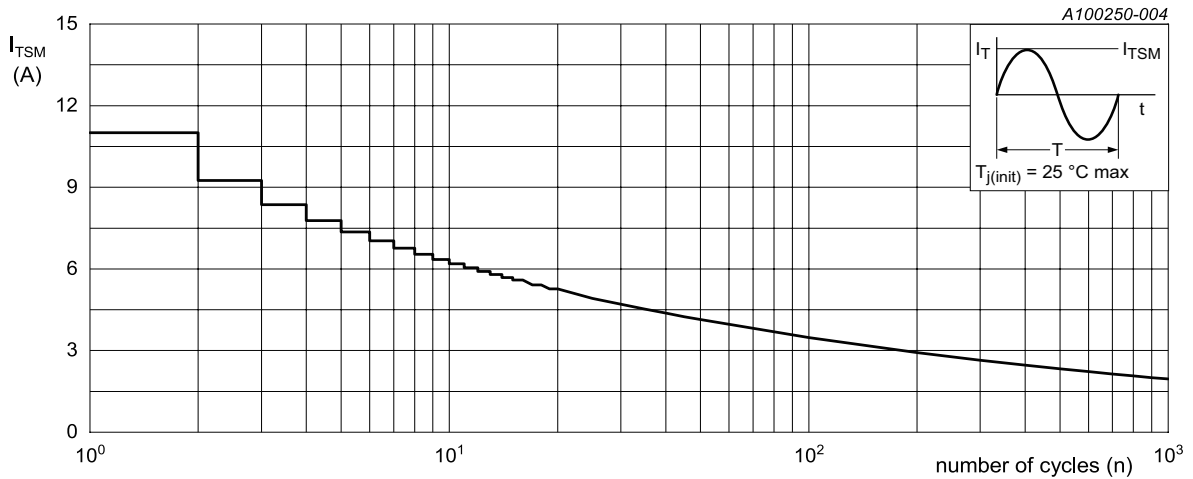


$f = 50\text{ Hz}$ ;  $T_{sp} = 111^{\circ}\text{C}$   
**Fig. 2. RMS on-state current as a function of surge duration; maximum values**



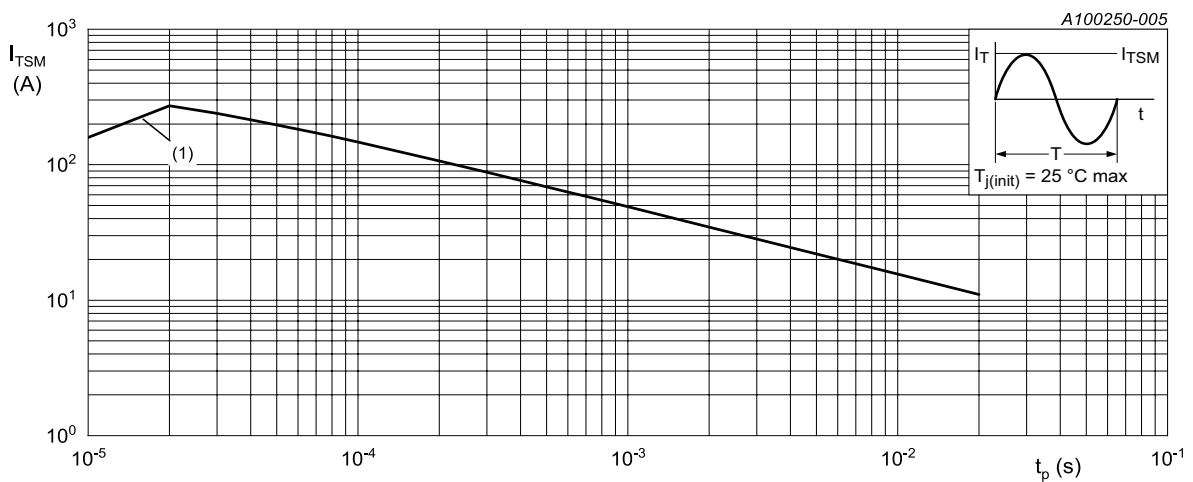
$\alpha$  = conduction angle  
 $a$  = form factor =  $I_{T(RMS)} / I_{T(AV)}$

Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values



f = 50 Hz

Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



$t_p \leq 20$  ms ;  
 (1)  $di_T/dt$  limit

Fig. 5. Total power dissipation as a function of RMS on-state current; maximum values

## 9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol         | Parameter  | Conditions   | Notes | Min | Typ | Max | Unit |
|----------------|--|--|-------|-----|-----|-----|------|
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point | full cycle; <a href="#">Fig 6</a>                    |       | -   | -   | 25  | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient      | in free air; printed-circuit board mounted; pad area |       | -   | 65  | -   | K/W  |

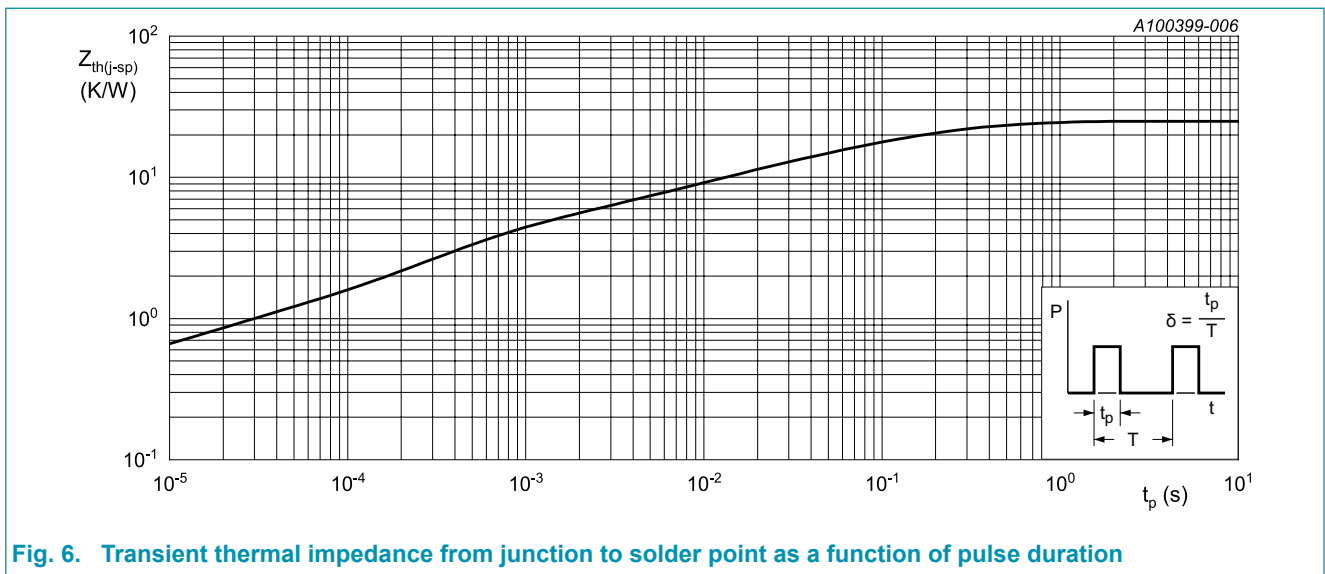


Fig. 6. Transient thermal impedance from junction to solder point as a function of pulse duration

## 10. Characteristics

Table 7. Characteristics

| Symbol                         | Parameter                             | Conditions  | Notes | Min | Typ | Max | Unit       |
|--------------------------------|---------------------------------------|---|-------|-----|-----|-----|------------|
| <b>Static characteristics</b>  |                                       |   |       |     |     |     |            |
| $I_{GT}$                       | gate trigger current                  | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2+ G+;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 7</a>                                       |       | 0.5 | -   | 10  | mA         |
|                                |                                       | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2+ G-;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 7</a>                                       |       | 0.5 | -   | 10  | mA         |
|                                |                                       | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2- G-;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 7</a>                                       |       | 0.5 | -   | 10  | mA         |
| $I_L$                          | latching current                      | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2+ G+;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 8</a>                                       |       | -   | -   | 12  | mA         |
|                                |                                       | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2+ G-;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 8</a>                                       |       | -   | -   | 20  | mA         |
|                                |                                       | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2- G-;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 8</a>                                       |       | -   | -   | 12  | mA         |
| $I_H$                          | holding current                       | $V_D = 12\text{ V}$ ; $T_J = 25\text{ °C}$ ; <a href="#">Fig. 9</a>   |       | -   | -   | 12  | mA         |
| $V_T$                          | on-state voltage                      | $I_T = 0.85\text{ A}$ ; $T_J = 25\text{ °C}$ ; <a href="#">Fig. 10</a>  |       | -   | -   | 1.6 | V          |
| $V_{GT}$                       | gate trigger voltage                  | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; $T_J = 25\text{ °C}$ ;<br><a href="#">Fig. 11</a>  |       | -   | -   | 1.5 | V          |
|                                |                                       | $V_D = 400\text{ V}$ ; $I_T = 0.1\text{ A}$ ; $T_J = 125\text{ °C}$   |       | 0.2 | -   | -   | V          |
| $I_D$                          | off-state current                     | $V_D = 800\text{ V}$ ; $T_J = 150\text{ °C}$  |       | -   | -   | 2   | mA         |
| $I_R$                          | reverse current                       | $V_R = 800\text{ V}$ ; $T_J = 150\text{ °C}$  |       | -   | -   | 2   | mA         |
| <b>Dynamic characteristics</b> |                                       |   |       |     |     |     |            |
| $dV_D/dt$                      | rate of rise of off-state voltage     | $V_{DM} = 536\text{ V}$ ; $T_J = 150\text{ °C}$ ; ( $V_{DM} = 67\%$ of $V_{DRM}$ ); exponential waveform;<br>$R_{GK} = 100\ \Omega$         |       | 600 | -   | -   | V/ $\mu$ s |
| $dI_{com}/dt$                  | rate of change of commutating current | $V_D = 400\text{ V}$ ; $T_J = 125\text{ °C}$ ; $I_{T(RMS)} = 0.8\text{ A}$ ;<br>$dV_{com}/dt = 10\text{ V}/\mu\text{s}$ ; gate open circuit |       | 1.6 | -   | -   | A/ms       |

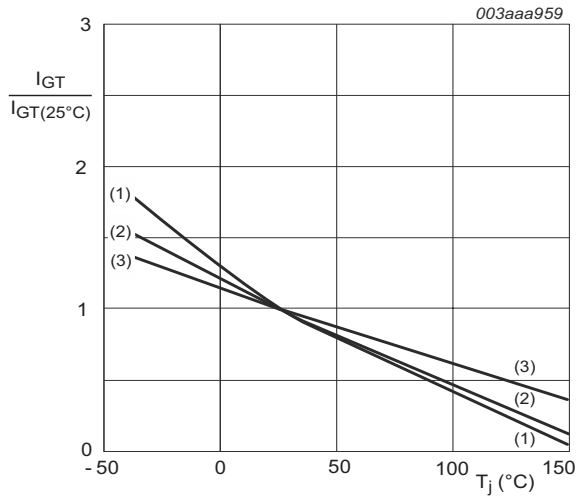


Fig. 7. Normalized gate trigger current as a function of junction temperature

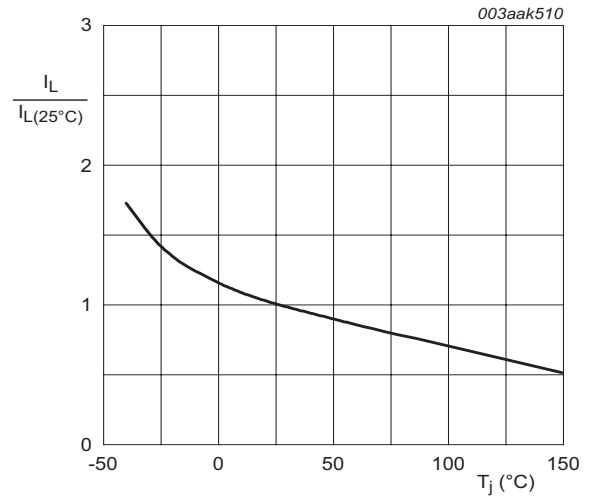


Fig. 8. Normalized latching current as a function of junction temperature

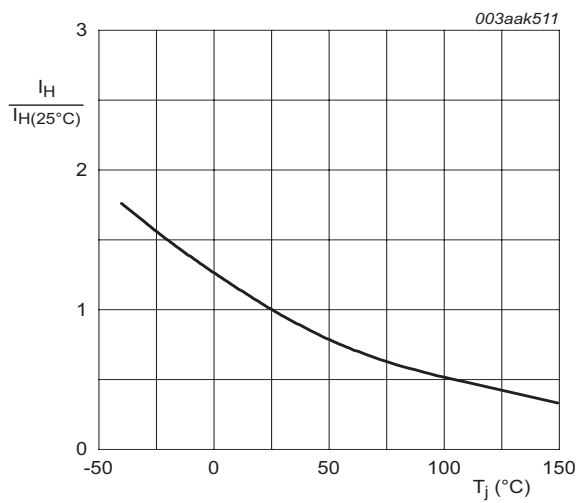
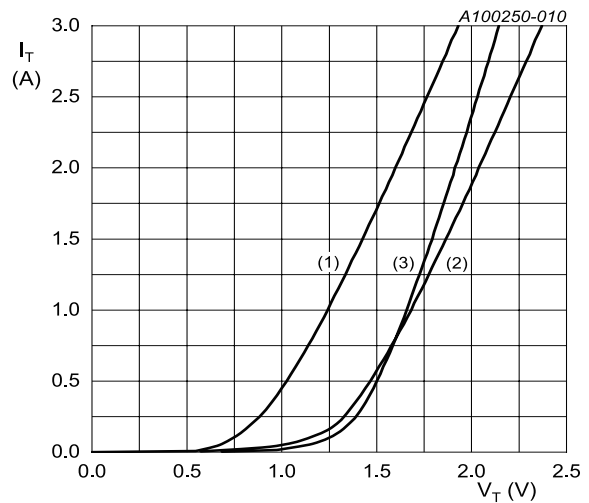


Fig. 9. Normalized holding current as a function of junction temperature



$V_o = 1.286 \text{ V}$ ;  $R_s = 0.3824 \Omega$   
 (1)  $T_j = 150^{\circ}\text{C}$ ; typical values  
 (2)  $T_j = 150^{\circ}\text{C}$ ; maximum values  
 (3)  $T_j = 25^{\circ}\text{C}$ ; maximum values

Fig. 10. On-state current as a function of on-state voltage

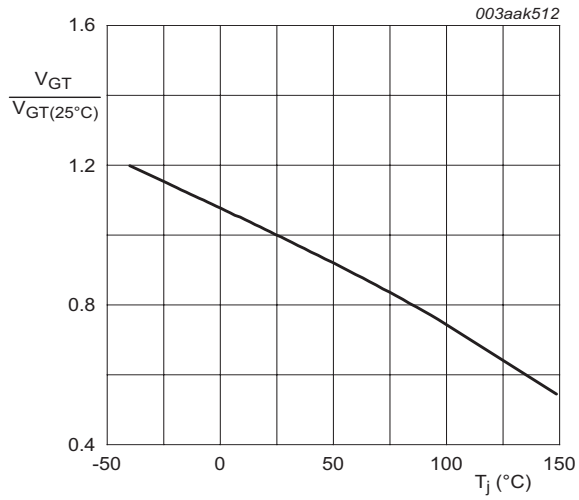
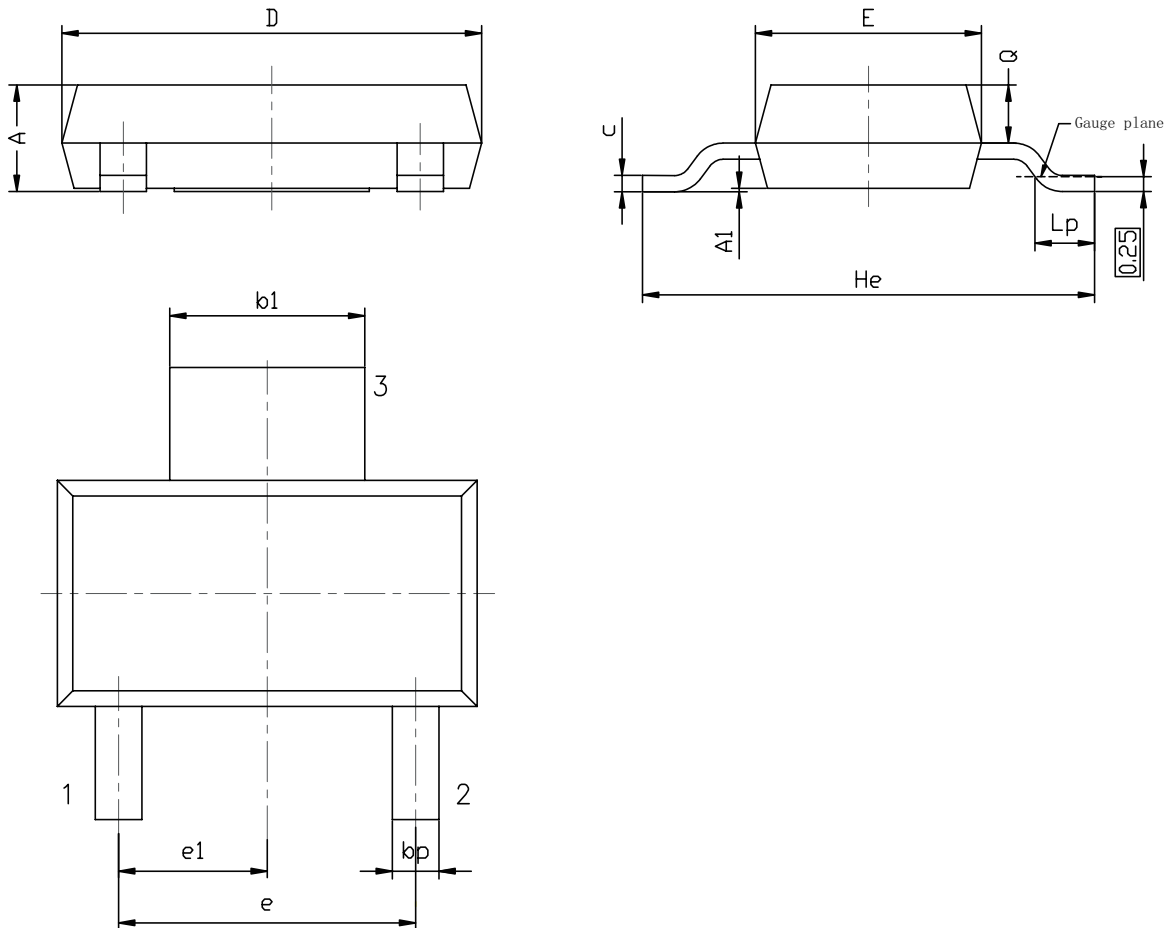


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

### 11. Package outline



| Unit | A   | A1   | bp   | b1   | c    | D    | E    | e    | e1   | He   | Lp   | Q    |      |
|------|-----|------|------|------|------|------|------|------|------|------|------|------|------|
| mm   | Min | 1.50 | 0.01 | 0.66 | 2.90 | 0.23 | 6.30 | 3.30 | 4.50 | 2.20 | 6.70 | 0.75 | 0.82 |
|      | Max | 1.81 | 0.12 | 0.85 | 3.13 | 0.35 | 6.70 | 3.70 | 4.70 | 2.40 | 7.30 | 1.20 | 0.93 |

## 12. Legal information

### Data sheet status

| Document status [1][2]         | Product status [3] | Definition  |
|--------------------------------|--------------------|---|
| Objective [short] data sheet   | Development        | This document contains data from the objective specification for product development. |
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